
APPENDIX 3: Photographs of test setup

Conducted emission

Front



Side



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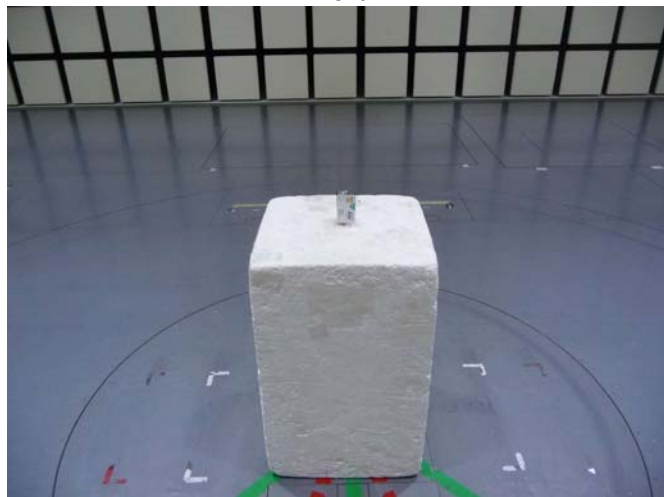
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Telephone : +81 463 50 6400

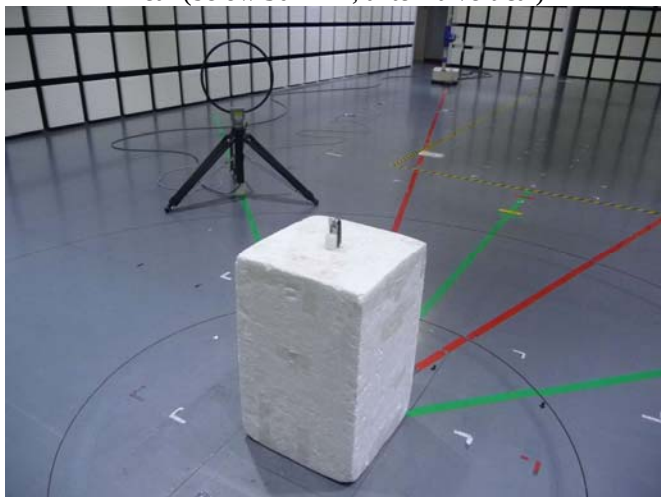
Facsimile : +81 463 50 6401

Radiated emission

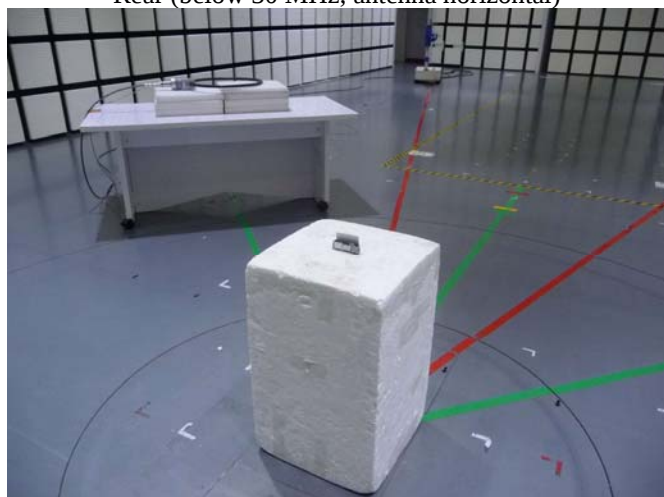
Front



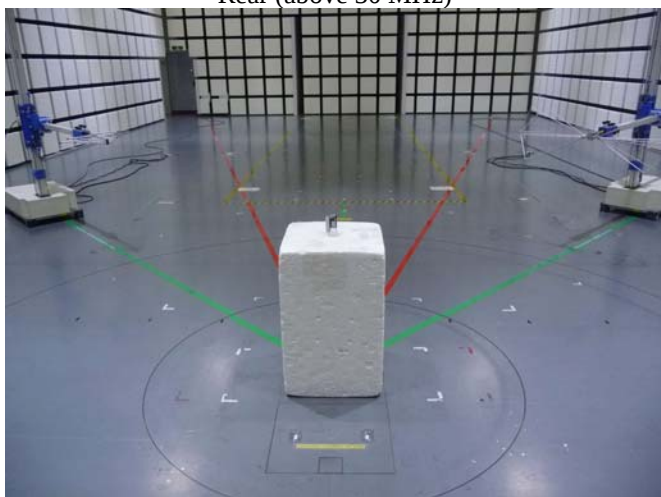
Rear (below 30 MHz, antenna vertical)



Rear (below 30 MHz, antenna horizontal)



Rear (above 30 MHz)



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Pre-check of Worst Case Position

(with tag)
X-axis



(without tag)
X-axis



Y-axis



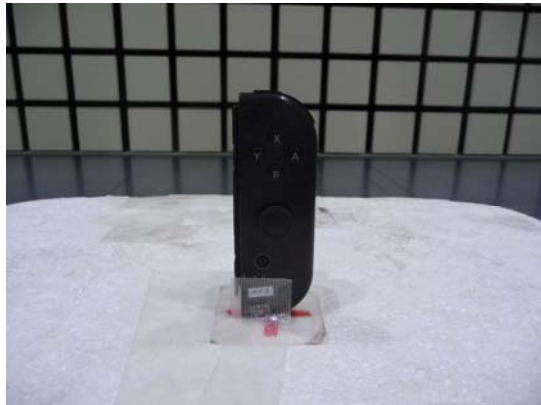
Y-axis



Z-axis



Z-axis



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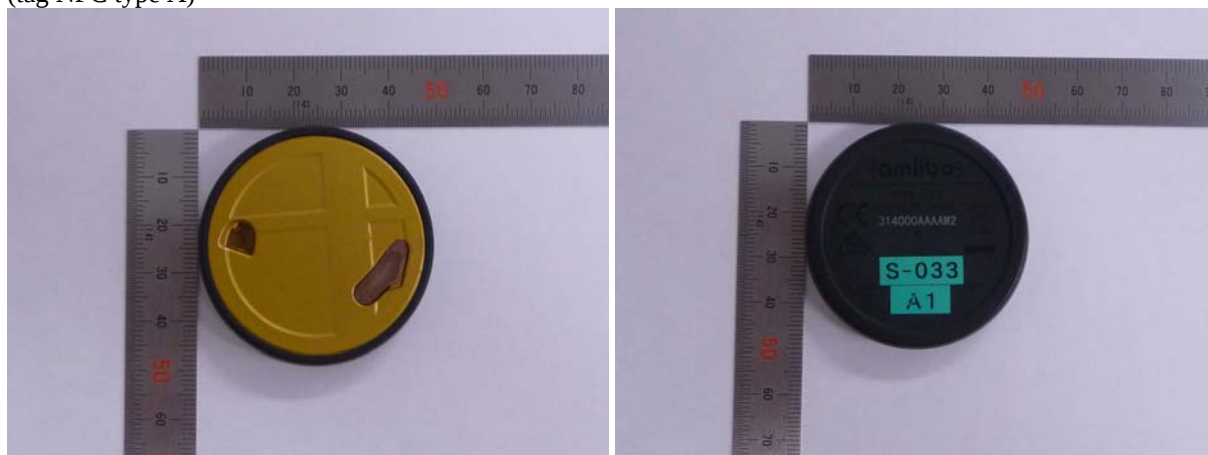
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Tag used for the test as representative

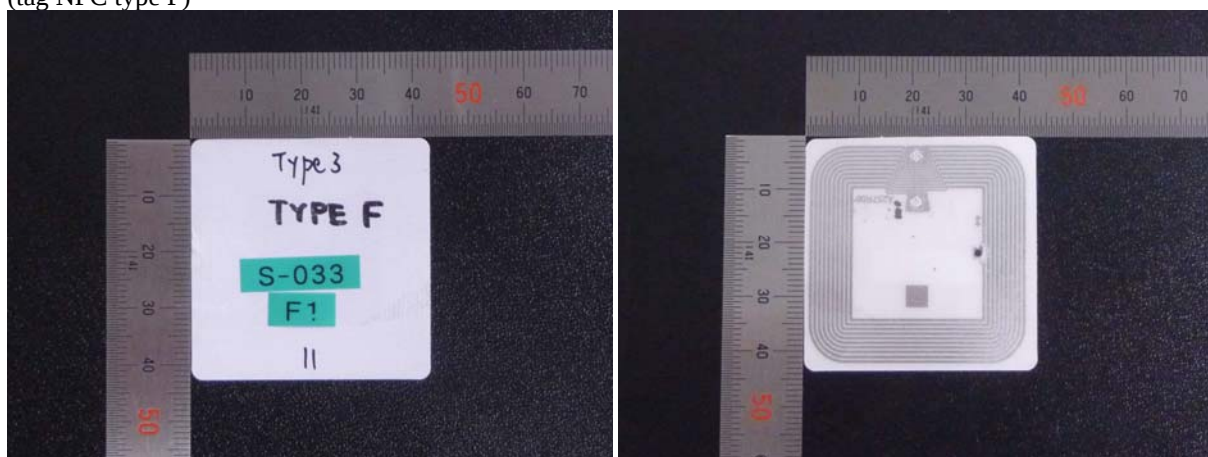
(tag NFC type A)



(tag NFC type B)



(tag NFC type F)



END OF REPORT

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